Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/809,855	TAKEUCHI ET AL.	
Examiner	Art Unit	
Hae M. Hyeon	2830	

	SEARCHED			
Class	Subclass	Date	Examiner	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
439	76.2	6405	hmh
439	949	V	1

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
Update Search Done	6/05	hmh	
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